# **SMD Power Inductor**

**HPC8040NF-Series** 

REV   DATE   DESCRIPTION   APPROVED   CHECKED   DRAWN		ECN HISTORY LIST								
### (株)	REV	DATE	DESCRIPTION	APPROVED	CHECKED	DRAWN				
	1.0	14/08/07	新發行	楊祥忠	詹偉特	徐允珮				
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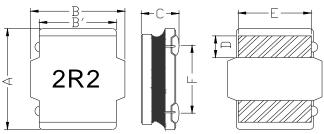
# **SMD Power Inductor**

**HPC8040NF-Series** 

## 1. Features

- 1. This specification applies Low Profile Power Inductors.
- 2. 100% Lead(Pb) & Halogen-Free and RoHS compliant.

## 2. Dimension

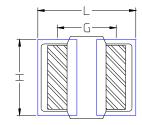


,			<u>~</u>				
Series	A(mm)	B(mm)	B'(mm)	C(mm)	D(mm)	E(mm)	F(mm)
HPC8040NF	80+03	8.0+0.3	6.3+0.2	3.7+0.3	2 0+0 3	6.0+0.3	5.5+0.3

# Halogeni Halogen-free



## **Recommendend Land pattern**



L(mm)	G(mm)	H(mm)
8.5	5.3	6.3

# 3. Part Numbering



A: Series

B: Dimension

C: Type

D: Inductance

2R2=2.20uh 100=10uh,101=100uh,102=1000uh

E: Inductance Tolerance  $K=\pm 10\%, M=\pm 20\%, Y=\pm 30\%.$ 

A/B\*C

marking direction cannot decide polarity. Color: Black, unidirectional

magnetic shielding

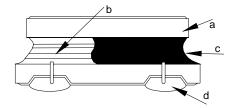
# 4. Specification

			Rated current				DCR	
Part Number	L0 (uH)	Tolerance		ure current is (A)		Saturation current I sat (A)		
	@ 0 A		Тур	Max	Тур	Max	±20%.	
HPC8040NF-1R0YTH	1.00	±30%	8.50	8.00	13.80	13.00	8.2	
HPC8040NF-1R4YTH	1.40	±30%	8.20	7.80	11.80	11.20	10.0	
HPC8040NF-1R5YTH	1.50	±30%	8.00	7.70	11.50	11.00	10.0	
HPC8040NF-2R2YTH	2.20	±30%	7.40	6.90	9.80	9.20	11.5	
HPC8040NF-3R3YTH	3.30	±30%	6.60	6.20	8.00	7.50	15.0	
HPC8040NF-4R7MTH	4.70	±20%	5.80	5.30	6.70	6.00	19.5	
HPC8040NF-5R6MTH	5.60	±20%	5.40	5.20	6.20	5.80	22.0	
HPC8040NF-6R8MTH	6.80	±20%	5.10	5.00	5.60	5.10	25.0	
HPC8040NF-100MTH	10.0	±20%	4.60	4.20	5.00	4.30	33.0	
HPC8040NF-150MTH	15.0	±20%	3.60	3.20	4.00	3.60	50.0	
HPC8040NF-220MTH	22.0	±20%	2.90	2.45	3.10	2.80	73.0	
HPC8040NF-330MTH	33.0	±20%	2.30	2.10	2.60	2.10	100	
HPC8040NF-470MTH	47.0	±20%	2.00	1.70	2.20	1.90	135	
HPC8040NF-560MTH	56.0	±20%	1.75	1.60	1.90	1.60	160	
HPC8040NF-680MTH	68.0	±20%	1.65	1.50	1.75	1.50	205	
HPC8040NF-820MTH	82.0	±20%	1.40	1.30	1.60	1.40	230	
HPC8040NF-101MTH	100	±20%	1.20	1.10	1.45	1.20	300	
HPC8040NF-121MTH	120	±20%	1.10	1.00	1.30	1.10	350	
HPC8040NF-151MTH	150	±20%	0.98	0.90	1.20	1.03	410	
HPC8040NF-181MTH	180	±20%	0.91	0.83	1.04	0.94	490	
HPC8040NF-221MTH	220	±20%	0.85	0.76	0.99	0.90	610	

#### Note:

- $2. \ \ \text{Testing Instrument}: \\ \text{HP4284A,CH11025,CH3302,CH1320 ,CH1320S LCR METER / Rdc:CH502BC MICRO OHMMETER.} \\$
- 3. Heat Rated Current (Irms) will cause the coil temperature rise approximately  $\Delta t$  of 40°C (keep 1min.).
- 4. Saturation Current (Isat) will cause L0 to drop 30% typical. (keep quickly).
- 5. The part temperature (ambient + temp rise) should not exceed 125°C under worst case operating conditions. Circuit design, component, PCB trace size and thickness, airflow and other cooling provisions all affect the part temperature. Part temperature should be verified in the end application.
- ${\small 6. \ Special \ inquiries \ besides \ the \ above \ common \ used \ types \ can \ be \ met \ on \ your \ requirement.} \\$

# 5. Material List



NO	Items	Materials
а	Core	Ferrite Core
b	Wire	Copper Wire
С	Coating	Epoxy with magnetic
d	Solder	Lead free

# 6. Reliability and Test Condition

Item	Performance	Test Condition			
Operating temperature	-40~+125℃				
Storage temperature	-40~+125℃ (on board)				
Electrical Performance Test					
Inductance		HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter.			
DCR	Refer to standard electrical characteristics list.	CH502BC,Agilent33420A Micro-Ohm Meter.			
Saturation Current (Isat)	△L30% typical.	Saturation DC Current (Isat) will cause L0 to drop △L(%)(keep quickly).			
Heat Rated Current (Irms)	Approximately △T≦40°C	Heat Rated Current (Irms) will cause the coil temperature rise △T(°C) without core loss.  1. Applied the allowed DC current(keep 1 min.).  2. Temperature measured by digital surface thermometer			
Reliability Test					
Life Test		Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020DClassification Reflow Profiles) Temperature: 125±2°C (Bead) Temperature: 85±2°C (Inductor) Applied current: rated current Duration: 1000±12hrs Measured at room temperature after placing for 24±2 hrs			
Load Humidity		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC  J-STD-020DClassification Reflow Profiles Humidity: 85±2 % R.H, Temperature: 85℃±2℃  Duration: 1000hrs Min. with 100% rated current Measured at room temperature after placing for 24±2 hrs			
Thermal shock	Appearance: No damage. Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020DClassification Reflow Profiles Condition for 1 cycle Step1: -40±2°C 30±5min Step2: 25±2°C ≤0.5min Step3: 105±2°C 30±5min Number of cycles: 500 Measured at room temperature after placing for 24±2 hrs			
Vibration		Oscillation Frequency: 10~2K~10Hz for 20 minutes Equipment: Vibration checker Total Amplitude:1.52mm±10% Testing Time: 12 hours(20 minutes, 12 cycles each of 3 orientations) °			
		Type Value duration (D) Wave change (g's) (ms) Wave form (Vi)ft/sec			
Shock		SMD 1500 0.5 Half-sine 15.4			
		Lead 100 6 Half-sine 12.3			
Bending		Shall be mounted on a FR4 substrate of the following dimensions: >=0805:40x100x1.2mm <0805:40x100x0.8mm Bending depth: >=0805:1.2mm <0805:0.8mm duration of 10 sec.			

Item	Performance	Test Method and Remarks
Soderability	More than 95% of the terminal electrode should be covered with solder °	Preheat: 150°C,60sec. ∘ Solder: Sn99.5%-Cu0. 5% ∘ Temperature: 245±5°C ∘ Flux for lead free: Rosin. 9.5% ∘ Dip time: 4±1sec ∘ Depth: completely cover the termination
Resistance to Soldering Heat		Number of heat cycles: 1  Temperature (°C)  Time(s)  Temperature ramp/immersion and emersion rate  260 ±5(solder temp)  10 ±1  25mm/s ±6 mm/s
Terminal Strength	Appearance: No damage. Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020DClassification Reflow Profiles With the component mounted on a PCB with the device to be tested, apply a force (>0805:1kg , <=0805:0.5kg)to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested.

# 7. Soldering and Mounting

#### (1) Soldering

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. TAI-TECH terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

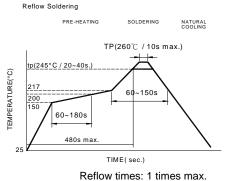
#### (2) Solder re-flow:

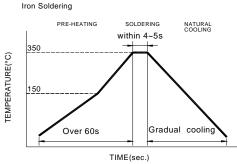
Recommended temperature profiles for re-flow soldering in Figure 1.

## (3) Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

- Preheat circuit and products to 150°C
- · Never contact the ceramic with the iron tip
- · Use a 20 watt soldering iron with tip diameter of 1.0mm
- 355°C tip temperature (max)
- 1.0mm tip diameter (max)
- · Limit soldering time to 4~5sec.





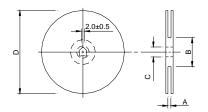
Iron Soldering times: 1 times max.

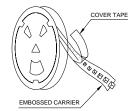
Fig.1

Fig.2

# 8. Packaging Information

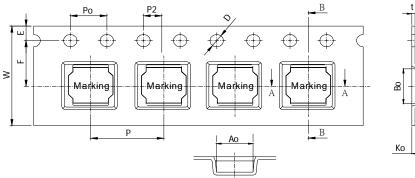
## (1) Reel Dimension

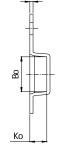


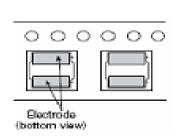


Туре	A(mm)	B(mm)	C(mm)	D(mm)	
13"x16mm	16.5±0.5	80±2.0	13.5±0.5	330±3.0	

#### (2) Tape Dimension





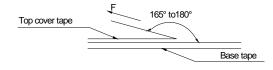


Series	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	w(mm)	t(mm)	Emm)	F(mm)	D(mm)	Po(mm)	P2(mm)
HPC	8040	8.4±0.1	8.4±0.1	4.3±0.1	12±0.1	16±0.3	0.4±0.1	1.75±0.1	7.5±0.1	1.5±0.1	4.0±0.1	2.00±0.1

## (3) Packaging Quantity

НРС	8040
Reel	1000
Inner box	2000
Carton	8000

## (4) Tearing Off Force



The force for tearing off cover tape is 10 to 130 grams in the arrow direction under the following conditions(referenced ANSI/EIA-481-C-2003 of 4.11 stadnard).

Room Temp. (°C)	Room Humidity (%)	Room atm (hPa)	Tearing Speed mm/min
5~35	45~85	860~1060	300

#### **Application Notice**

- Storage Conditions (component level)
  To maintain the solderability of terminal electrodes:
  1. TAIPAQ products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
- 2. Temperature and humidity conditions: Less than 40 $^{\circ}$ C and 60 $^{\circ}$ RH. 3. Recommended products should be used within 12 months form the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.

# 9. Typical Performance Curves

